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# Local and Medium Range Order Influence on the Magnetic Behavior of Sputtered Ga-Rich FeGa Thin Films

3 A. Muñoz-Noval,<sup>†,‡</sup> E. Salas-Colera,<sup>\*,§,||</sup><sup>©</sup> and R. Ranchal<sup>‡</sup>

<sup>4</sup> <sup>†</sup>Department of Applied Chemistry, Hiroshima University, Higashi-Hiroshima, Hiroshima 739-8527, Japan

s <sup>‡</sup>Departamento de Física de Materiales, Facultad de Ciencias Físicas, Universidad Complutense de Madrid, Ciudad Universitaria 6 s/n, Madrid 28040, Spain

7 <sup>§</sup>BM25-Spline, The Spanish CRG at the ESRF, Grenoble 38043, France

<sup>8</sup> <sup>II</sup>Instituto de Ciencia de Materiales de Madrid-CSIC, Madrid 28049, Spain



**ABSTRACT**: We have investigated the influence of the growth power on the structural properties of  $Fe_{100-x}Ga_x$  (x ca. 29) 9 films sputtered in the ballistic regime in the oblique incidence. By means of different structural characterizations, mainly X-ray 10 diffraction and X-ray absorption spectroscopy, we have reached a deeper understanding about the influence of the local and 11 medium range order on the magnetic behavior of Ga-rich FeGa thin films. On the one hand, the increase of the growth power 12 reduces the crystallite size (medium order) that promotes the decrease of the coercive field of the layers. On the other hand, the 13 growth power also determines the local order as it controls the formation of the A2, B2, and D0<sub>3</sub> structural phases. The increase 14 of the uniaxial in-plane magnetic anisotropy with growth power has been correlated with the enhancement of both Ga pairs and 15 a tetragonal distortion. The results presented in this work give more evidence about the magnetic anisotropy sources in Ga-rich 16

FeGa alloys, and therefore, it helps to understand how to achieve a better control of the magnetic properties in this family of alloys.

## 19 INTRODUCTION

 $_{20}$  Fe<sub>100-x</sub>Ga<sub>x</sub> compounds are among the most relevant magneto-21 strictive materials with excellent ductility, chemical stability, <sup>22</sup> and free of rare-earths. Their magnetostriction coefficient  $(\lambda_s)$ 23 depends on the Ga content and on the samples processing, 24 showing two maxima around 18 and 28 at. % Ga being possible 25 to enhance  $\lambda_s$  by means of fast cooling.<sup>1</sup> The highest  $\lambda_s$  value is 26 achieved in quenched samples at the second maxima (Ga-rich 27 FeGa alloys) of the Ga-dependent magnetostriction curve,<sup>1</sup> 28 although up-to-date, major part of the research has been 29 focused on the relationship between the microstructural,  $_{30}$  magnetic, and magnetoelastic properties at the first peak.<sup>2-14</sup> 31 Less has been reported on  $Fe_{100-x}Ga_x$  alloys with compositions 32 around the second maxima, in spite of their intrinsic 33 interest.<sup>1,15-20</sup> The metastable diagram phase predicts an A2 34 single phase state just for Ga contents up to 21 at. %.<sup>1</sup> It is 35 precisely when this A2 single phase state is obtained by means 36 of quenching when the magnetostriction reaches its highest 37 value in the first maximum of magnetostriction. The 38 magnetostriction in the second peak is also larger when

quenching, but in general it exhibits an A2, B2, and D0<sub>3</sub> phase <sup>39</sup> mixture.<sup>1,15</sup> Therefore, the origin of this second magneto-<sup>40</sup> striction maximum seems to involve more factors than the first <sup>41</sup> one. Because magnetostriction and magnetic anisotropy are <sup>42</sup> closely related, investigations about the latter are crucial to <sup>43</sup> understand the former. <sup>44</sup>

Recently, the correlation between microstructure and the 45 development of an in-plane magnetic anisotropy in Ga-rich 46 FeGa alloys around the second peak has been reported.<sup>19,20</sup> In 47 particular, the local range order promoted by the use of 48 different sputtering regimes, ballistic or diffusive, was reported 49 in a previous work.<sup>19</sup> To study the local range order, the use of  $_{50}$  X-ray absorption fine structure (XAFS) measurements is 51 crucial because they can provide information about the 52 electronic structure and local geometry of the scattering  $_{53}$  atom when using X-ray absorption near edge structure 54

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55 (XANES) and about the degree of disorder by means of 56 extended XAFS (EXAFS).<sup>9,19-22</sup> In the sputtering process, 57 neutrals (atoms ejected from the target upon the impact of <sup>58</sup> energetic particles) suffer collisions on their movement from <sup>59</sup> the target to the substrate.<sup>23-25</sup> If the number of collisions is 60 low, neutrals keep their momentum and energy till the 61 substrate, and the sputtering growth takes place under ballistic 62 flow.<sup>23</sup> In this regime, sputtered atoms arrive to the substrate 63 with the same energy and momentum they acquired in the 64 target. The ballistic flow regime increased the amount of 65 ordered phases with respect to the diffusive, while the direction 66 of the uniaxial magnetic easy axis seems to be set by the 68 recently reported its use for controlling the magnetic 69 anisotropy in exchange-biased InMn/FeGa bilayers.<sup>27</sup> Another 70 key parameter in the sputtering technique is the growth power, 71 tightly related to the growth rate that influences the 72 microstructure and morphology of films at different 73 scales.<sup>28-31</sup>

In this work, we address the influence of the growth power rs on Ga-rich FeGa thin films sputtered in the ballistic regime, in which we have observed that it is possible to fix the Ga content within a very narrow range. This allows us to better correlate he microstructure (medium and local range) promoted during sputtering growth with the magnetic properties of the layers. Thanks to this investigation, it has obtained a deeper understanding about the magnetic anisotropy origin in Gazrich FeGa thin films and how to control it.

#### 83 METHODS

84 Samples were grown by the direct current (dc) magnetron 85 sputtering technique at room temperature on glass substrates. 86 The deposition was carried out in oblique incidence with an 87 angle of 25° between the vapor beam and the sample plane. 88 The distance between the target and the substrate was 9 cm 89 that corresponds to the ballistic regime for the growth 90 conditions used in this work.<sup>19</sup> We have used films of Mo 91 with a thickness of 20 nm as buffer and capping layers. Mo was 92 deposited by dc sputtering with a power of 90 W in an Ar 93 pressure of 0.3 Pa. The 200 nm-thick FeGa films were 94 deposited from a target with a composition of Fe<sub>72</sub>Ga<sub>28</sub> with a 95 diameter of 5 cm and a thickness of 2 mm. The thickness of 96 the layers has been chosen in order to promote the existence of 97 a clear in-plane magnetic anisotropy.<sup>20</sup> We have used an Ar 98 pressure of 0.3 Pa in all cases, whereas the growth power 99 ranged from 50 to 90 W. The target voltage was monitored 100 during the layers growth being around 430 V in all cases. In 101 order to avoid effects related to the target ageing, the samples 102 were deposited consecutively. The structure of the samples is 103 glass/Mo (20 nm)/FeGa (200 nm)/Mo (20 nm).

104 X-ray diffractometry (XRD) in the Bragg–Brentano 105 configuration was performed in a Philips X'Pert MPD using 106 the Cu K $\alpha$  wavelength (1.5406 Å). The composition of the 107 samples was analyzed by means of the energy dispersive X-ray 108 spectroscopy in a Leica 440 scanning electron microscope 109 operated at 8 kV and 1.5 nA. The in-plane hysteresis loops 110 were measured at room temperature in a vibrating sample 111 magnetometer from LakeShore.

The XAFS measurements were performed at BM25-Spline 113 in the ESRF, the European Synchrotron in Grenoble (France). 114 Both the Fe and Ga K-edges (7112 and 10367 eV, 115 respectively) were analyzed measuring at fluorescence yield 116 mode. The EXAFS data were treated applying standard 120

procedures employing the Demeter package.<sup>32</sup> The fits were <sup>117</sup> carried out in *r*-space using theoretical functions from FEFF8.4 <sup>118</sup> code calculated from crystallographic standards.<sup>33,34</sup> <sup>119</sup>

#### RESULTS AND DISCUSSION

As can be observed in Table 1, the Ga content of the FeGa 121 the layers is almost independent on the growth power. In this 122

Table 1. Ga Content as Measured by EDS, Lattice Parameter (*a*), and Grain Size (*D*) Inferred from XRD, and Parameters Inferred from EXAFS: Global Expansion/ Contraction Coefficient of the Shells Respect to the Tabulated Crystallographic Reference ( $\Delta R$ ), Debye–Waller Factor of the First Ga–Ga/Fe Shell ( $\sigma^2$ Ga–Ga1), and Debye–Waller Factor of the Second Ga–Ga/Fe Shell ( $\sigma^2$ Ga–Ga2) for Fe<sub>100-x</sub>Ga<sub>x</sub> Alloys Deposited in the Ballistic Regime at Different Growth Powers (*P*) in the Oblique Deposition

P = 50  W	P = 70  W	P = 90  W
28(1)	29(1)	30(1)
2.894(2)	2.897(2)	2.899(2)
140(5)	104(5)	82(5)
35	20	15
$2.2 \times 10^4$	$3.0 \times 10^{4}$	$4.1 \times 10^{4}$
0.08(1)	0.08(1)	0.08(1)
0.0074(3)	0.0074 (3)	0.0073(3)
0.0233(20)	0.0235(20)	0.0230(20)
	P = 50 W 28(1) 2.894(2) 140(5) 35 2.2 × 10 <sup>4</sup> 0.08(1) 0.0074(3) 0.0233(20)	$P = 50 W P = 70 W$ $28(1) 29(1)$ $2.894(2) 2.897(2)$ $140(5) 104(5)$ $35 20$ $2.2 \times 10^4 3.0 \times 10^4$ $0.08(1) 0.08(1)$ $0.0074(3) 0.0074 (3)$ $0.0233(20) 0.0235(20)$

work, the Ga content is constrained between 28 and 30 at. % 123 when power increases from 50 to 90 W. Considering the 124 experimental error, we can assume that Ga content is fixed for 125 the studied power range. All the layers exhibit similar X-ray 126 diffraction patterns with a main peak related to the  $\alpha$ -Fe (110) 127 reflection as obtained in previous works (Figure 1).<sup>19,20,35</sup> The 128 fl



Figure 1. X-ray diffraction patterns in the Bragg–Brentano configuration for the FeGa films deposited in the ballistic regime at different growth powers: 90 W (90), 70 W (70), and 50 W (50). A Mo layer is included for further comparisons. The curves are vertically shifted for clarity.

lattice parameter (*a*) calculated using this (110) reflection <sup>129</sup> slightly increases with the growth power, in agreement with the <sup>130</sup> almost insignificant increase of the Ga content (Table 1). The <sup>131</sup> Scherrer's equation (eq 1) using the  $\alpha$ -Fe(110) reflection has <sup>132</sup> been employed to estimate the crystallite size (*D*). We have <sup>133</sup> used this parameter *D* to characterize the medium range order <sup>134</sup>

$$D = \frac{Q\lambda}{\beta \cos \theta} \tag{1}_{135}$$

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**Figure 2.** Hysteresis loops at room temperature measured in the sample plane for different directions between the reference direction and the applied magnetic field: ( $\odot$ ) 0° and ( $\blacksquare$ ) 90° for FeGa films deposited in the ballistic regime at different growth powers: (a) 50, (b) 70, and (c) 90 W. (d) In-plane magnetic anisotropy (K) and coercive field in the hard axis as a function of the growth power.

136 where Q is a shape factor taken as 0.9,  $\lambda$  is the radiation 137 wavelength (1.5406 Å),  $\beta$  is the full width at half maximum, 138 and  $\theta$  is the Bragg angle of the considered reflection, 139 respectively. Here, we are assuming that variations on the 140 full width at half maximum of the diffraction peak are only 141 related to D. The observed decrease of the crystallite size with 142 the growth power indicates a reduction of the medium range 143 order (Table 1).

f2

The growth power has also an influence on the magnetic 144 145 behavior of the Ga-rich FeGa layers. In Figure 2a-c, we 146 present the room temperature in-plane hysteresis loops with 147 the applied magnetic field forming different angles with respect 148 to the reference direction (sputtering incidence direction). A 149 clear in-plane uniaxial magnetic anisotropy can be observed in 150 all the considered samples, which is enhanced upon the 151 increase of the growth power (Figure 2d). The easy axis 152 coincides with the oblique incidence direction in agreement 153 with previous works.<sup>19,26</sup> As it can also be observed in the set 154 of magnetic loops, there is a decrease of the coercive field  $(H_{\rm C})$ 155 in the hard axis with the growth power (Figure 2d). We can 156 understand this behavior by taking into account the depend-157 ence between the growth power and the crystallite size. It has 158 been reported that magnetic domains with size below the 159 magnetic coherence length ( $\delta$ ) present an increase of  $H_{\rm C}$  with 160 the grain size  $.^{36} \delta$  can be calculated by means of eq 2

$$\delta = \sqrt{\frac{A}{K}}$$
(2)

162 where *A* is the exchange coupling constant and *K* the 163 anisotropy energy of the FeGa layers. Taking into account *A* 164 =  $1.6 \times 10^{-11} \text{ J} \cdot \text{m}^{-112}$  and the experimental values for *K* (Table 165 1), we obtain a  $\delta$  of at least 19 nm. The highest estimated 166 crystallite diameter determined by XRD data was 14 nm (see 167 Table 1). Then, the smaller value of *D* in comparison to  $\delta$  can 168 explain the coercivity diminishment with the growth power.

<sup>169</sup> Up to this point, there seems to be a correlation between the <sup>170</sup> coercivity and the medium range order originated by the <sup>171</sup> growth power increase. If the grain size had any influence on the magnetic anisotropy, it would be to decrease the 172 anisotropy as generally observed in nanocrystalline systems 173 due to the average of local fluctuating anisotropies.<sup>36</sup> 174 Nevertheless, we have experimentally obtained the opposite 175 behavior, that is, the magnetic anisotropy is higher in the layers 176 with smaller grains. Therefore, the in-plane magnetic 177 anisotropy must have another physical origin. In order to get 178 a deeper insight into the structural properties of the layers, it is 179 necessary to reach information about the local order because, 180 in previous works, it has been reported to be closely related to 181 the magnetic anisotropy.<sup>9,19–21</sup> Therefore, we have also tackled  $_{182}$ a more detailed study of the local structure of the layers by 183 performing XAFS spectroscopy. The fitting of the EXAFS 184 spectra performed in the r-space (Figure 3a) provides the 185 f3 structural parameters included in Table 1. The fittings of the 186 short-range structure of Ga have been carried out considering a 187 two atomic shell model in which the first shell is a Ga-Fe and 188 the second a Ga-Ga shell. The structural parameters included 189 in the model comprise a global expansion/contraction 190 coefficient of the shells respect to the tabulated crystallographic 191 reference ( $\Delta R$ ), the Debye–Waller factor ( $\sigma^2$ ), and the 192 nonstructural parameter  $\Delta E_0$ , which accounts for the energy 193 shifts of the theoretical calculated spectrum respect to the 194 energy grid of the experimental one.<sup>37</sup> All the structural 195 parameters are quite similar, being feasible to consider all of 196 them equal within the experimental error (Table 1). The  $\Delta R_{197}$ parameter accounts for the shell distance dilatation respect to 198 the tabulated value, and it is somehow related to the lattice 199 parameter a. The fact that all the studied samples have 200 approximately the same  $\Delta R$  value is compatible with the fact 201 that the experimental lattice parameters are also similar for all 202 the growth powers (Table 1). In the case of the  $\sigma^2$ , we can also 203 assume that the static local disorder can be considered the 204 same for all the layers. Therefore, in this study in which all the 205 samples have a very close composition, EXAFS does not 206 provide relevant information about differences between 207 samples. 208



Figure 3. XAFS spectra of the FeGa layers grown by sputtering in the ballistic regime for increasing growth powers, 50, 70, and 90 W. (a) Fourier transform of the EXAFS spectra and best fits. (b) Detail of the main peak (white line) of the absorption edge in XANES for the different growth powers. (c) Subtracted spectra with respect to that for 50 W. For example,  $\mu(90 \text{ W}) - \mu(50 \text{ W})$  indicates the subtraction between the spectra for layers deposited at 90 and 50 W, respectively.

We have also addressed the study of the local range order by 209 210 XANES. In general, when dealing with a complex mixture of 211 phases like in these sputtered samples, the study can only be 212 done qualitatively. In Figure 3b, the main peak (also defined as 213 white line) of the XANES experimental spectra of the studied 214 FeGa layers is presented. Similar XANES results can be found 215 in works about Ga-rich FeGa thin films.<sup>19,20</sup> The shape and 216 intensity of the white line is related to the proportion of the 217 different structural phases that can be present in these samples 218 that are: A2, B2, and D03. In order to highlight the differences, 219 we present in Figure 3c, the subtracted spectra with respect to 220 the layer deposited at the lowest growth power. For example, 221  $\mu(90 \text{ W}) - \mu(50 \text{ W})$  indicates the subtraction between the 222 spectra for layers deposited at 90 and 50 W, respectively. The 223 subtracted spectra exhibit one main negative peak (at around 224 10 374 eV) followed by a maximum (at around 10 400 eV), 225 both of them indicated by arrows in Figure 3c. The negative 226 peak has been assigned to Ga-pairs formed upon the alignment 227 of B2 cell units, whereas the maximum at higher energies is an 228 indication of the tetragonal distortion of the also B2 cell.<sup>20</sup> 229 Therefore, the increase of the uniaxial in-plane magnetic 230 anisotropy with the growth power is related to the enhance-231 ment of both, Ga-pairs and tetragonal distortion, as previous 232 works have already pointed out.<sup>19,20</sup> Theoretical calculations  $_{233}$  have shown that rather than the direct nucleation of the D0<sub>3</sub> 234 phase, it appears from a cascade of congruent orderings 235 starting from disorder A2 Ga-rich aggregates: A2  $\rightarrow$  B2  $\rightarrow$ 236 D0<sub>3</sub>.<sup>38</sup> The increase of the growth power can prevent the 237 crystallization from B2 to D03, keeping B2 in a higher 238 proportion respect to D0<sub>3</sub>.

The experimental results presented in this work are 239 240 fundamental to shed light upon the origin of the magnetic 241 anisotropy in FeGa thin films. Here, we have observed that the

local range order can be tuned by means of the growth power 242 when the Ga concentration is fixed in a very narrow range. In 243 this study, the magnetic anisotropy is controlled by both, Ga- 244 pairs and tetragonal distortion. A similar conclusion was 245 obtained when studying the effect of the thickness.<sup>20</sup> 246 Therefore, the correlation between magnetic anisotropy and 247 both, Ga-pairs and tetragonal distortion, is fundamental in 248 FeGa alloys, and therefore, it can be used to tailor the magnetic 249 anisotropy by means of the local order. In addition, the growth 250 power determines the coercivity of the layers through the 251 medium range order. 252

CONCLUSIONS 253

We have investigated the influence of the growth power on the 254 magnetic properties of Ga-rich  $Fe_{100-x}Ga_x$  (x ca. 29) thin films 255 deposited by sputtering in the ballistic regime in oblique 256 incidence. The experimental results show that the variation of 257 the growth power has a small effect on the Ga content being 258 possible to correlate the power with the structural and 259 magnetic properties of the layers. A decrease of the medium 260 range order can be observed, characterized by the grain size, as 261 the power is increased that reduces the coercivity of the films. 262 The growth power also determines the local range order that 263 has an impact on the in-plane magnetic anisotropy upon the 264 enhancement of both, Ga-pairs and tetragonal distortion. This 265 work adds clues to understand the magnetic behavior of FeGa 266 thin films and opens the way to tune the magnetic anisotropy 267 by means of the local range order. 268

#### AUTHOR INFORMATION 269 **Corresponding Author** 270 \*E-mail: salascol@esrf.fr. Phone: +33 476 88 26 35. 271 ORCID © 272 E. Salas-Colera: 0000-0001-7812-268X 273 Notes 2.74 The authors declare no competing financial interest. 275 276

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